Structural Change around Si Atoms in P₂O₅–SiO₂ Binary Glasses before and after Annealing by ²⁹Si MAS NMR Spectroscopy

Shinichi Sakida,*1 Tokuro Nanba,2 and Yoshinari Miura2

¹Environmental Management and Safety Section, Health and Environment Center, Okayama University,

3-1-1 Tsushima-Naka, Okayama 700-8530

²Department of Environmental Chemistry and Materials, Faculty of Environmental Science and Technology,

Okayama University, 3-1-1 Tsushima-Naka, Okayama 700-8530

(Received July 25, 2006; CL-060843; E-mail: sakida@cc.okayama-u.ac.jp)

The ²⁹Si MAS NMR spectra of P_2O_5 –SiO₂ binary glasses were measured before and after annealing to examine the local structure around Si atoms in the glasses. The glasses were composed of SiO₆ octahedra and Q₄ (SiO₄ tetrahedra with four bridging oxygens). By increasing the P₂O₅ content, the fractions of SiO₆ octahedra increased and those of Q₄ decreased. The fractions of SiO₆ octahedra increased by 6–8% in the range of 29.7 to 47.4 mol % P₂O₅ by annealing for 5 h. This result was found for the first time in binary glasses. On the basis of the results obtained, the local structure around Si atoms in the glasses and the structural change by annealing are discussed.

 P_2O_5 -bearing silicate glasses are of considerable interest in material science such as glass-to-metal seals, laser hosts, optical fibers, bioglasses, and waste vitrification technology. Silicon atoms in most silicate glasses are tetrahedrally coordinated by four oxygen atoms. In phosphosilicate ternary glasses, however, the formation of SiO₆ octahedra has been reported by many studies.^{1–7} The increase in the proportion of SiO₆ octahedra by a slower cooling rate has also been reported.^{2,5,6} On the other hand, studies and information about the structure of phosphosilicate binary glasses.^{1–7} Therefore, it is interesting to investigate the structures of phosphosilicate binary glasses and the structural change by annealing because annealing corresponds to a slower cooling rate.

In the present work, 29 Si MAS NMR spectra were measured for P₂O₅–SiO₂ binary glasses before and after annealing to reveal the local structure around Si atoms in the glasses and the structural change by annealing.

Phosphosilicate binary glasses with an $xP_2O_5 \cdot (100 - x)$ -SiO₂ composition (x = 20, 30, 40, 50, and 60) in mol% were prepared. 0.2 mol% Fe₂O₃ was added in order to shorten the relaxation time of the Si nucleus with I = 1/2. High-purity reagents of NH₄H₂PO₄, SiO₂, and Fe₂O₃ were used as starting materials. A 15–20 g batch of well-mixed reagents was calcined at 500 °C for 1 h and then melted at 1500 °C for 1 h in an alumina crucible covered with a lid. The melt was cooled to room temperature by removing the crucible from the furnace and placing the crucible directly onto a firebrick. Half of all the prepared glasses was annealed at the respective glass-transition temperatures for 5 h. All the prepared glasses before and after annealing were transparent and showed no sign of crystallization by XRD and phase separation by scanning electron microscopy (SEM; JEOL JSM-6300).

The compositions of the glasses were analyzed by chemical analysis. An amount of alumina contamination in the glasses

was estimated by ²⁷Al MAS NMR. The glass transition temperatures (T_g) of the glasses were determined with a Rigaku Thermoflex TAS 300 TG 8110D TG-DTA. The measurements were carried out at a heating rate of 10 K·min⁻¹. The ²⁹Si and ²⁷Al MAS NMR spectra of powdered P₂O₅-SiO₂ glasses were obtained at 59.584 and 78.160 MHz, respectively, with a Varian UNITY INOVA 300 MAS FT-NMR spectrometer (7.05 T). The acquisition parameters for ²⁹Si MAS NMR had a pulse length of 2.0 µs ($\pi/4$ pulse length), an accumulation of 10,000 scans and a pulse delay of 1.0 s. The spinning rate was 8.0 kHz. Polydimethylsilane was used as a secondary standard whose chemical shift was $\delta = -34.0$ ppm from TMS. The acquisition parameters for ²⁷Al MAS NMR had a pulse length of 0.6 μ s ($\pi/18$ pulse length), an accumulation of 1000 scans and a pulse delay of 1.0 s. The spinning rate was 6.5 kHz. Chemical shifts were referenced to a 1 M AlCl₃ aqueous solution at 0 ppm.

The nominal and analyzed compositions, and T_g of the prepared glasses are given in Table 1. The actual compositions of the glasses deviated from the batch values because of evaporation of P₂O₅. Hereafter, the compositions of the glasses are described by analyzed compositions. The T_g of the glasses monotonously increased with an increase of P₂O₅ content. Alumina contamination in the glasses was within 1 mol % Al₂O₃.

Figures 1 and 2 show the ²⁹Si MAS NMR spectra of $xP_2O_5 \cdot (100 - x)SiO_2$ glasses (x = 20.0, 29.7, 36.5, 41.5, and 47.4) with no annealing and 5 h after annealing, respectively. The numerals in the figures denote isotropic chemical shifts (δ_{iso}). The spectra consist of one or two peaks. The large peaks with δ_{iso} values of -121 to -115 ppm and the small peaks of -217 to -213 ppm can be assigned to Q₄ (SiO₄ tetrahedra with four bridging oxygens) and SiO₆ octahedra,¹¹ respectively. Therefore, the formation of SiO₆ octahedra was observed from about 30 mol % P₂O₅.

The fractions of Q_4 and SiO₆ octahedra were estimated from the areas of the respective peaks. The error in the fractions of Q_4 and SiO₆ octahedra was within $\pm 1\%$. The fractions of Q_4 (top) and SiO₆ octahedra (bottom) as functions of the P₂O₅ content in

Table 1. Nominal and analyzed compositions and glass-transition temperatures (T_g) of P₂O₅-SiO₂ glasses

Glass composition/mol %		T /°C
Nominal	Analyzed	Ig/ C
20P ₂ O ₅ •80SiO ₂	20.0P ₂ O ₅ •80.0SiO ₂	523
$30P_2O_5 \cdot 70SiO_2$	29.7P ₂ O ₅ •70.3SiO ₂	536
$40P_2O_5 \cdot 60SiO_2$	$36.5P_2O_5 \cdot 63.5SiO_2$	545
$50P_2O_5 \cdot 50SiO_2$	$41.5P_2O_5 \cdot 58.5SiO_2$	550
$60P_2O_5 \cdot 40SiO_2$	$47.4P_2O_5 \cdot 52.6SiO_2$	562



Figure 1. ²⁹Si MAS NMR spectra of $xP_2O_5 \cdot (100 - x)SiO_2$ glasses (x = 20.0, 29.7, 36.5, 41.5, and 47.4) with no annealing.



Figure 2. ²⁹Si MAS NMR spectra of $xP_2O_5 \cdot (100 - x)SiO_2$ glasses (x = 20.0, 29.7, 36.5, 41.5, and 47.4) after 5 h annealing.

P₂O₅–SiO₂ glasses are plotted in Figure 3. The fraction of SiO₆ octahedra in the glasses containing $20.0 \text{ mol }\% P_2O_5$ and 29.7P₂O₅•70.3SiO₂ glass with no annealing is 0%. By increasing the P₂O₅ content, the fractions of SiO₆ octahedra increase and those of Q4 decrease almost linearly from 20 and 29.7 mol % P_2O_5 in glasses with 5 h annealing and no annealing, respectively. Thus, the increase of the P₂O₅ content is considered to make the formation of SiO₆ octahedra easy. The fractions of SiO₆ octahedra increase by 6-8% in the range of 29.7 to $47.4 \mod \% P_2O_5$ by 5h annealing, indicating that the formation of SiO₆ octahedra by annealing makes the glasses more thermodynamically stable. By the way, crystalline SiP_2O_7 consists of SiO₆ octahedra and PO₄ tetrahedra.¹² Therefore, the formation of SiO₆ octahedra in the glasses is considered to be caused by the formation of a more thermodynamically stable local structure, as seen in crystalline SiP₂O₇. The maximum fraction of SiO₆ octahedra in this work is 21.8% and smaller than



Figure 3. Plots of the fractions of Q_4 (top) and SiO₆ octahedra (bottom) as functions of P_2O_5 content in P_2O_5 –SiO₂ glasses.

the fractions of SiO₆ octahedra observed in phosphosilicate ternary glasses.¹⁻⁴ This suggests that the formation of SiO₆ octahedra is mainly due to the charge compensation by the third oxide (except P_2O_5 and SiO₂) but also somewhat due to the formation of a more thermodynamically stable local structure, as seen in crystalline SiP₂O₇.

In conclusion, P_2O_5 -SiO₂ binary glasses are composed of SiO₆ octahedra and Q₄. The formation of SiO₆ octahedra is observed from about 30 mol % P₂O₅. By increasing the P₂O₅ content, the fractions of SiO₆ octahedra increase and those of Q₄ decrease almost linearly from 20 and 29.7 mol % P₂O₅ in the glasses with 5 h annealing and no annealing, respectively. The fractions of SiO₆ octahedra increase by 6–8% in the range of 29.7 to 47.4 mol % P₂O₅ by 5 h annealing. The formation of SiO₆ octahedra in the glasses is considered to be caused by the formation of a more thermodynamically stable local structure, as seen in crystalline SiP₂O₇.

References

- 1 R. Dupree, D. Holland, M. G. Mortuza, *Nature* **1987**, *328*, 416.
- 2 M. Nogami, K. Miyamura, Y. Kawasaki, Y. Abe, J. Non-Cryst. Solids 1997, 211, 208.
- 3 H. Yamashita, H. Yoshino, K. Nagata, H. Inoue, T. Nakajin, T. Maekawa, J. Non-Cryst. Solids 2000, 270, 48.
- 4 S. Muthupari, M. E. Fleet, J. Non-Cryst. Solids 1998, 238, 259.
- 5 R. Dupree, D. Holland, M. G. Mortuza, J. A. Collins, M. W. G. Lockyer, J. Non-Cryst. Solids 1988, 106, 403.
- 6 R. Dupree, D. Holland, M. G. Mortuza, J. A. Collins, M. W. G. Lockyer, J. Non-Cryst. Solids 1989, 112, 111.
- 7 D. Li, G. M. Bancroft, M. E. Fleet, Am. Mineral. 1996, 81, 111.
- 8 T. L. Weeding, B. H. W. S. de Jong, W. S. Veeman, B. G. Aitken, *Nature* **1985**, *318*, 352.
- 9 N. Mochida, T. Sekiya, A. Ohtsuka, J. Ceram. Soc. Jpn. 1988, 96, 271.
- 10 T. Sekiya, N. Mochida, A. Ohtsuka, K. Uchida, J. Ceram. Soc. Jpn. 1988, 96, 571.
- 11 J. F. Stebbins, M. Kanzaki, Science 1991, 251, 294.
- 12 E. Tillmanns, W. Gebert, W. H. Baur, J. Solid State Chem. 1973, 7, 69.